

Modulating the phase transition temperature of giant magnetocaloric thin films by ion irradiation

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Magnetic refrigeration based on the magnetocaloric effect at room temperature is one of the most attractive alternatives to the current gas compression/expansion method routinely employed. Nevertheless, in giant magnetocaloric materials, optimal refrigeration is restricted to the narrow temperature window of the phase transition (T_c). In this work, we present the possibility of varying this transition temperature in the same giant magnetocaloric material by ion irradiation. We demonstrate that the transition temperature of iron rhodium thin films can be tuned by the bombardment of ions of Ne^{5+} with varying fluences up to 10^{14} ions cm^{-2} , leading to optimal refrigeration over a large 270–380 K temperature window. The T_c modification is found to be due to the ion-induced disorder and to the density of new pointlike defects. The variation of the phase transition temperature with the number of incident ions opens new perspectives in the conception of devices using giant magnetocaloric materials.

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I. INTRODUCTION

The current climatic situation motivates investments in research and development of more environmentally friendly technologies. In this context, the refrigerant systems based on the compression and expansion of an ideal gas can be replaced by more efficient devices using materials which heat up or cool down when a magnetic field is applied or removed [1,2]. This effect, named the magnetocaloric effect, occurs in all magnetic materials and is more pronounced in the proximity of phase transitions due to the entropy variation involved. Magnetocaloric materials with a phase transition near room temperature have seen their interest growing thanks to their promising properties in magnetic refrigeration [1,3–6] as well as in electricity generation [7–9] for daily life applications (refrigerators, air and water conditioning, etc.). Special attention has been recently devoted to magnetic materials that exhibit first-order phase transitions. In such systems, the entropy variation and the associated capacity of the material to cool down are higher than for second-order transitions. As a counterpart, this type of transition is generally characterized by an abrupt phase transformation that relegates the giant magnetocaloric effect in a small temperature window. Paradoxically, materials exhibiting a large magnetocaloric effect, and then a high potential refrigeration capacity, are less suitable for realistic refrigerator devices that should work at several tens of degrees.

To overcome this issue, existing partially also in standard magnetocaloric materials, considerable efforts have been done in the past years. In particular, magnetocaloric materials with different transition temperatures (T_c) were combined in the form of heterostructures [10–14] to enlarge the working temperature interval of magnetic refrigerators. In parallel, different methods to tune the transition temperature of giant magnetocaloric materials were investigated, among them,

the variation of chemical composition and doping [15–21] but also the application of external strains [12,22,23]. The fabrication of suitable sets of giant magnetocaloric materials heterostructures requires however the *ad hoc* synthesis of each individual component and a good thermal contact between them.

Here, we present an alternative method to tune the transition temperature based on the modification of giant magnetocaloric thin film properties using low-velocity heavy ions. More specifically, we demonstrate that changing the magnetic properties of epitaxial thin films of iron rhodium (FeRh) is possible in a controlled manner by impact of ions. FeRh, which is one of the most promising giant magnetocaloric materials, presents a magnetic phase transition of first order around $T_c = 375$ K between an antiferromagnetic phase at low temperature and a ferromagnetic phase at high temperature. During the transition, the pure ordered structure with B2 (Cs-Cl) symmetry does not change but the lattice volume increases by about 1%. At present, neither this high temperature of phase transition nor the restricted window of the entropy variation (~ 20 K) makes FeRh the best candidate for magnetic refrigeration. A variation of T_c has been obtained in the past in non-equiatomical [24] or doped FeRh [25]. In thin films of FeRh, only a T_c increase is obtained by doping [26,27]. For all these cases the T_c is modified to a given value on the entire sample and no gradient is achievable. In the following, we report on the effects of heavy-ion impact on the film properties, emphasizing the controlled modification of the transition temperature over a significant range. It is indeed the most relevant outcome for new conception of refrigeration devices.

II. EXPERIMENTAL DETAILS

A. Growth conditions

FeRh films with a 36 nm thickness are grown by radio-frequency sputtering from a stoichiometric $\text{Fe}_{50}\text{Rh}_{50}$ target onto (001)-oriented MgO substrates [28]. The growth is done at 630 °C with a power of 45 W and under an argon pressure of

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1×10^{-3} mbar. After growth, the films are annealed *in situ* at 730°C for 90 min under vacuum ($P = 1 \times 10^{-8}$ mbar). The epitaxial films are then capped by 3 nm of aluminum grown by dc sputtering at room temperature. The film thickness is determined by x-ray reflectivity.

B. Irradiation conditions

Ion irradiations are performed at an electron-cyclotron ion source, the SIMPA facility (the French acronym for the multicharged ion source of Paris, France) [29]. The FeRh/MgO thin film obtained by sputtering was cut into six pieces. Five of them are irradiated by Ne^{5+} ions with a kinetic energy of 25 keV and with an incident angle of 60° (between the normal of the surface and the ion beam), while the last one was kept pristine and used as a reference. With these irradiation conditions, the ions have an average penetration equal to half the thickness of the FeRh layer and are deposited in all its volume. At this energy, the nuclear elastic collisions between ions and FeRh atoms are the predominant processes [30]. They mainly induce pointlike defect vacancies or interstitial atoms. The number of those induced defects can be controlled through the quantity of incident ions per cm^2 , i.e., the fluence. To investigate the possibility to tune the properties of FeRh thin films by varying the number of induced defects, the five samples are irradiated with different fluences from 2.8×10^{12} to 1.1×10^{14} ions cm^{-2} with an uncertainty $\leq 8\%$. The number of ions per cm^2 impinging upon the targets is controlled by monitoring the ion beam intensity and the irradiation time. The fluence is determined “*in situ*” by using a position-sensitive Faraday cup array [31], which provides the beam intensity profile, coupled to a CCD camera that takes images of the sample before and during irradiation.

C. Magnetic and structural properties

Magnetic properties of the different samples are determined with a superconducting interference device (SQUID; Quantum Design MPMS-XL 7 T) and a vibrating sample magnetometer (VSM; Quantum Design PPMS 9 T). Before each measurement, the magnetic memory is deleted by applying a decreasing magnetic field oscillating around the zero average value. Magnetization curves as a function of magnetic field are acquired for two temperatures 100 K and 350 K (the highest temperature reachable by this magnetometer) between 0 and 7 T with steps of 0.01 T. The magnetization versus temperature curves are obtained with an applied magnetic field of 1 T and with a sweep rate of ± 2 K/min for all samples.

The irradiation effects on the FeRh layer structure are deduced by x-ray diffraction (XRD) measurements at room temperature ($T = 293 \pm 1$ K) before and after irradiation (Rigaku Smartlab model). The absence of sputtering induced by incident ions is checked with the x-ray reflectivity technique.

III. RESULTS AND DISCUSSION

From the x-ray diffraction pattern of the different samples, displayed in Fig. 1, several observations can be made. The B2 (Cs-Cl) phase is clearly visible through the presence of three diffraction peaks whatever the ion fluence. Those

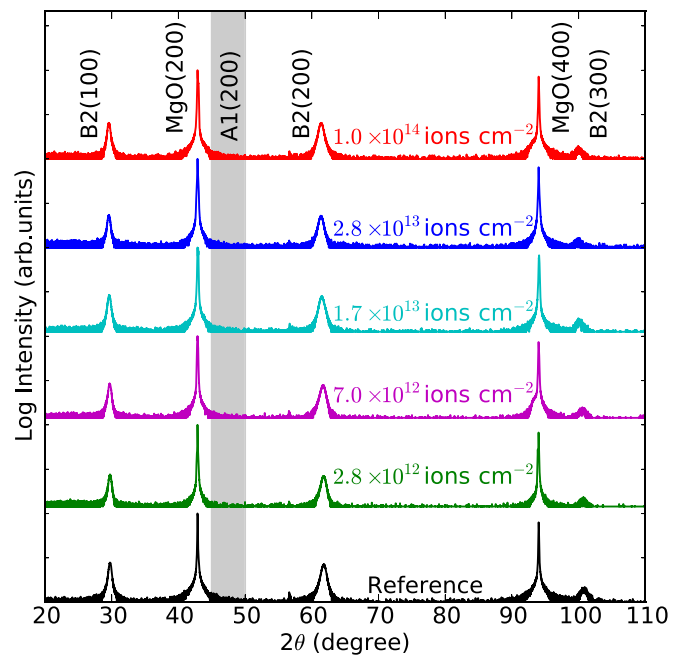


FIG. 1. X-ray diffraction patterns (θ - 2θ) for the reference and all irradiated samples submitted to different ion fluences. The data are normalized to the (200) peak intensity of the MgO substrate for all the samples.

peak intensities being barely affected, the irradiation does not amorphize the samples. In previous works [32–34], the B2 phase was found to coexist with an A1-type phase (disordered face-centered-cubic structure) which is paramagnetic and expected to appear in the gray area in Fig. 1. The absence of this phase in our XRD data attests to the high quality of the films and the low damage induced by ion impact. It means that those irradiations do not create a new crystalline phase, as an A1-type phase. Nevertheless, slight changes of the structural properties can be extracted from XRD. Indeed, the order parameter [Fig. 2(a)] and the out-of-plane lattice parameter [Fig. 2(b)] show a systematic variation with the ion fluence. The order parameter, which is the fraction of Fe and Rh atoms in their cubic site [35,36], reflects the disorder induced by irradiation.

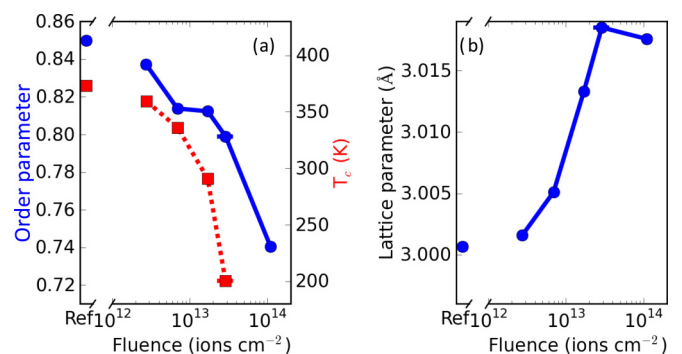


FIG. 2. (a) The order parameter (solid line) and T_c (dashed line) and (b) the lattice parameter of each sample as a function of the number of incident ions per cm^2 . The error bars are about the size of the symbols.

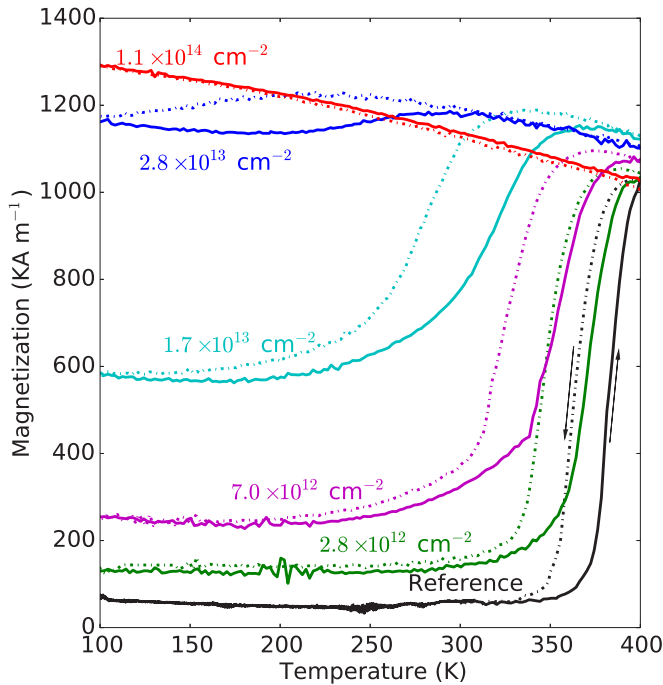


FIG. 3. The magnetization as a function of temperature for irradiated and reference samples. Data obtained, at 1 T, by a temperature increase (solid lines) and decrease (dash-dotted lines).

It can be calculated by $s = \sqrt{I_{\text{exp}}(001)/I_{\text{exp}}(002)}/1.07$ where $I_{\text{exp}}(hkl)$ are experimental intensities and 1.07 comes from theoretical intensities of the (hkl) Bragg reflection peak [35]. Figure 2(a) shows a decrease of this parameter from 0.85 to 0.73. Hence, the ion bombardment generates disorder into the FeRh thin film leading to a slight modification of the lattice. Indeed, the out-of-plane parameter gradually expands as a function of the irradiation fluence and reaches a relative expansion of 0.56% in the most irradiated sample [Fig. 2(b)]. This expansion is attributed to the induced disorder which enlarged the unit cell.

The increase in disorder leads to the modification of the antiferromagnetic interaction between Fe atoms and changes the resulting sample magnetization. Figure 3 represents magnetization as a function of temperature for different fluences. First, it appears that irradiation induces a shift of the antiferromagnetic (AF) to ferromagnetic (F) transition temperature, as plotted on Fig. 2(a) (dashed line). Second, the magnetization at low temperature builds as a function of the irradiation fluence (Fig. 3) due to the creation of a stable and persistent F phase. The robustness of the induced modifications has been tested repeating magnetization curves at different temperatures with a time interval of more than 2 years and after several temperature cycles up to 400 K without significant changes of the magnetic properties. On the other hand, at high temperature, the magnetization does not change drastically, presenting only a slight increase as a function of the received ion fluence, followed by a decrease after a peak at 1.7×10^{13} ions cm^{-2} .

It is worth noting that those irradiation effects on the magnetic properties of FeRh thin films impact directly their ability to refrigerate. Actually, magnetocaloric materials are

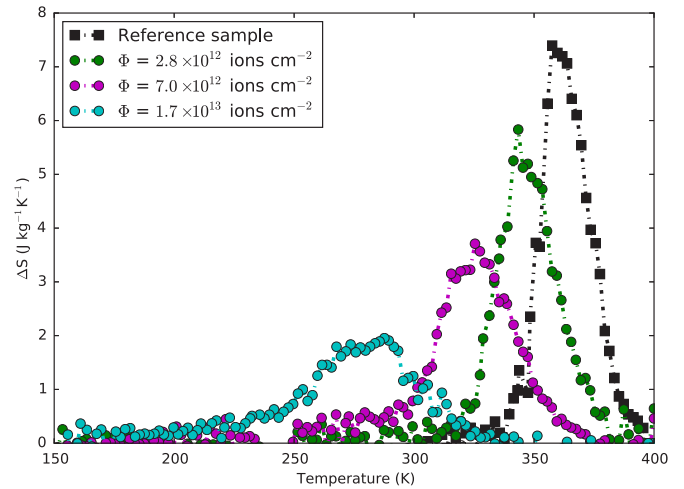


FIG. 4. Entropy variation as a function of the temperature for the reference sample as well as three irradiated samples. The variation was determined from isofield magnetization curves for magnetic fields ranging from 0 to 2 T.

characterized by their cooling capacity, q . This capacity is defined as the integration of the entropy variation ΔS within a fixed temperature interval. Here, ΔS is the entropy variation generated by a 2 T magnetic field at a fixed temperature. It is calculated from the sum of the derived curves of the magnetization versus decreasing temperature at various magnetic fields, applying the same procedure as in Ref. [37], from 0.2 T to 2 T with steps of 0.2 T. The evolution of ΔS with temperature is shown in Fig. 4 for the sample irradiated with a fluence of 1.7×10^{13} ions cm^{-2} and the reference one. As expected, ΔS is maximal at the temperature of the phase transition, 290 K for the irradiated sample and 375 K for the reference one. The integration of the ΔS peak over the full width at half maximum gives the cooling capacity for the reference sample [2,9], $q = 144 \text{ J kg}^{-1}$, while for the irradiated one, $q = 84 \text{ J kg}^{-1}$. The cooling capacity is then reduced by only a factor 2 for a shift of temperature of 85 K. This reduction is mainly due to the enhancement of the magnetization at low temperature with the ion fluence.

To enlighten the interpretation of our results, we recall what has been found in previous studies. The increase of magnetization at low temperature, as shown above, was already observed at 20 K in bulk FeRh and thin-film samples (with thicknesses ranging from 0.2 mm to 80 nm) irradiated with energetic projectiles (ions and electrons) [32–34,38–40] and in FeRh thin films (with a thickness of 30 nm) irradiated with 30 keV Ga ions [41]. Our results demonstrate that the disorder, induced by ion irradiation, is at the origin of the reduction of the AF exchange interaction. This reduction is more pronounced when the ion fluence increases, i.e., with the number of defects produced during ion collisional cascades. The possible role of ion implantation in the increase of magnetization can be excluded. Indeed, previous comparative experiments [41] dedicated to the irradiation of FeRh thin films (30–80 nm) with fast (10 MeV iodine) and slow ions (30 keV gallium), i.e., without and with ion implantation of the ions in the films, respectively, show a similar behavior to the magnetization evolution with the fluence.

The AF phase is very sensitive to the local modification of the symmetry and periodicity of the lattice. This is due to the variation of the local magnetic exchange terms leading to the stabilization of the F phase even at low temperature as experimentally observed [42,43] and theoretically predicted [44]. Moreover, the observed shift in T_c can also be related to the induced disorder. Recently, theoretical study suggests that this shift is due to off-stoichiometry, namely Fe antisites that are connected to the defect density. Those *ab initio* calculations prove that slight off-stoichiometry induces a dramatic drop in T_c [45], reflecting a compositional high sensitivity. The relation between the defect density and the T_c shift is also observed in experiments on FeRh thin films annealed at different temperatures [46]. From our measurements we clearly show the strong correlation (Fig. 2) between the defect density (proportional to the fluence), the order parameter, and the shift of transition temperature. This correlation unambiguously supports this theoretical interpretation.

IV. CONCLUSIONS AND PERSPECTIVES

FeRh thin films of 36 nm thickness have been irradiated with Ne^{5+} ions at 25 keV using different fluences. Ion impact modifies the properties of the magnetocaloric samples. When varying the fluence from 0 to 10^{14} ions cm^{-2} , we observe that the magnetization increases at low temperature. This behavior is due to the progressive extinction of the antiferromagnetic interaction within the material showing that irradiation-induced defects promote the persistent ferromagnetic phase which does not participate in the phase transition. Moreover, these defects amplify the disorder giving rise to a decrease of the transition temperature (T_c) due to a stabilization of the F phase at lower temperature. The study presented here on nanometric magnetocaloric materials allows us to highlight the mechanisms

at the origin of the T_c drop. In particular, we demonstrate the existence of a clear correlation between the shift of T_c , the defect density, and the induced disorder in the material. Moreover, the relationship between T_c and the ion fluence provides a method to decrease and tune T_c , keeping an efficient refrigerant power in a temperature window of about 120 K around room temperature. The production of a single giant magnetocaloric thin film presenting different T_c at different locations of the same material becomes possible thanks to this technique [47]. Such sample could be readily produced with a spatial gradient of ion intensity or by modulating the irradiation time at different locations in the film. It allows one to get rid of the synthesis of different magnetocaloric materials and their subsequent critical assembly. In particular, thin films with a spatial modulation of T_c could be useful in cooling millimeter-electronic compounds for example or even in thermal energy harvesting devices [48,49]. Finally, in principle, this technique could also be generalized to bulk magnetocaloric materials, presenting a first-order phase transition, for the development of efficient refrigerant or thermomagnetic generator “macro” devices. In that respect further investigations are being carried out using more energetic heavy ions to modify the transition temperature of micro- and millimetric samples, the typical size of powder grains and plates of active magnetocaloric materials in magnetic refrigerators.

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